

Features

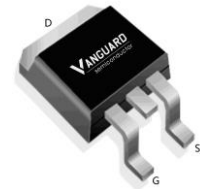
- P-Channel, -5V Logic Level Control
- Enhancement mode
- Low on-resistance $R_{DS(on)}$ @ $V_{GS}=-4.5V$
- Fast Switching and High efficiency
- 100% Avalanche Tested
- Pb-free lead plating; RoHS compliant


Halogen-Free

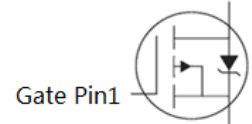
Part ID	Package Type	Marking	Tape and reel information
VS3506ATD	TO-263	3506ATD	1000pcs/Reel

V_{DS}	-30	V
$R_{DS(on),TYP}$ @ $V_{GS}=-10V$	6	m Ω
$R_{DS(on),TYP}$ @ $V_{GS}=-4.5V$	9	m Ω
I_D	-100	A

TO-263



Drain Pin2



Gate Pin1

Source Pin3

Maximum ratings, at $T_A=25^\circ C$, unless otherwise specified

Symbol	Parameter	Rating	Unit
$V_{(BR)DSS}$	Drain-Source breakdown voltage	-30	V
V_{GS}	Gate-Source voltage	± 20	V
I_S	Diode continuous forward current	$T_C=25^\circ C$	-100 A
I_D	Continuous drain current @ $V_{GS}=-10V$	$T_C=25^\circ C$	-100 A
		$T_C=100^\circ C$	-71 A
I_{DM}	Pulse drain current tested ①	$T_C=25^\circ C$	-400 A
I_{DSM}	Continuous drain current @ $V_{GS}=-10V$	$T_A=25^\circ C$	-15 A
		$T_A=70^\circ C$	-12 A
EAS	Avalanche energy, single pulsed ②	132	mJ
P_D	Maximum power dissipation	$T_C=25^\circ C$	94 W
P_{DSM}	Maximum power dissipation ③	$T_A=25^\circ C$	2 W
MSL		Level 3	
T_{STG}, T_J	Storage and Junction Temperature Range	-55 to 175	$^\circ C$
Thermal Characteristics			
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	1.6	$^\circ C/W$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	$^\circ C/W$

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
Static Electrical Characteristics @ T_J = 25°C (unless otherwise stated)						
V _{(BR)DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =-250μA	-30	--	--	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-30V, V _{GS} =0V	--	--	-1	μA
	Zero Gate Voltage Drain Current(T _J =125°C)	V _{DS} =-30V, V _{GS} =0V	--	--	-100	μA
I _{GSS}	Gate-Body Leakage Current	V _{GS} =±20V, V _{DS} =0V	--	--	±100	nA
V _{GS(TH)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =-250μA	-1.2	-1.6	-2.3	V
R _{DS(ON)}	Drain-Source On-State Resistance ④	V _{GS} =-10V, I _D =-30A	--	6	8	mΩ
R _{DS(ON)}	Drain-Source On-State Resistance ④	V _{GS} =-4.5V, I _D =-20A	--	9	12	mΩ
Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise stated)						
C _{iss}	Input Capacitance	V _{DS} =-15V, V _{GS} =0V, f=1MHz	2800	3810	4800	pF
C _{oss}	Output Capacitance		400	545	700	pF
C _{rss}	Reverse Transfer Capacitance		300	400	500	pF
R _g	Gate Resistance	f=1MHz		3.9		Ω
Q _g	Total Gate Charge	V _{DS} =-15V, I _D =-30A, V _{GS} =-10V	--	65	--	nC
Q _{gs}	Gate-Source Charge		--	16.1	--	nC
Q _{gd}	Gate-Drain Charge		--	18.1	--	nC
Switching Characteristics						
t _{d(on)}	Turn-on Delay Time	V _{DD} =-15V, I _D =-30A, R _G =3.0Ω, V _{GS} =-10V	--	14.4	--	ns
t _r	Turn-on Rise Time		--	11.2	--	ns
t _{d(off)}	Turn-Off Delay Time		--	99.5	--	us
t _f	Turn-Off Fall Time		--	47.5	--	us
Source- Drain Diode Characteristics @ T_J = 25°C (unless otherwise stated)						
V _{SD}	Forward on voltage	I _{SD} =-30A, V _{GS} =0V	--	-0.9	-1.2	V
t _{rr}	Reverse Recovery Time	T _J =25°C, I _{sd} =-30A, V _{GS} =0V	--	37	--	ns
Q _{rr}	Reverse Recovery Charge	di/dt=-100A/μs		35		nC

NOTE:

- ① Repetitive rating; pulse width limited by max junction temperature.
- ② Limited by T_{Jmax}, starting T_J = 25°C, L = 0.5mH, R_G = 25Ω, I_{AS} = -18A, V_{GS} = -10V. Part not recommended for use above this value
- ③ The power dissipation P_{DSM} is based on R_{θJA} and the maximum allowed junction temperature of 150°C.
- ④ Pulse width ≤ 300μs; duty cycles ≤ 2%.



Typical Characteristics

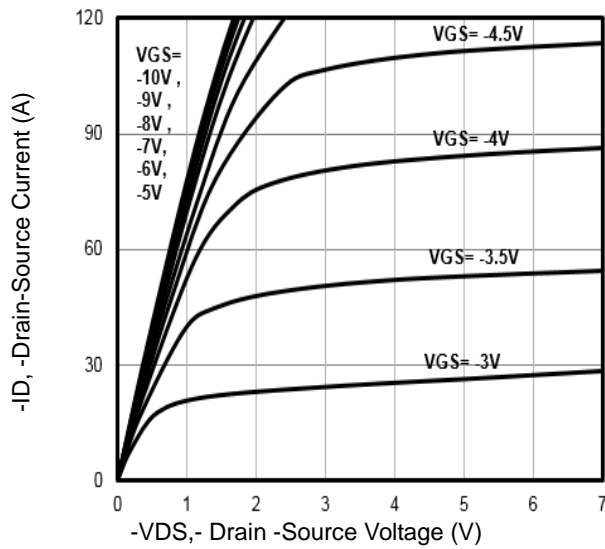


Fig1. Typical Output Characteristics

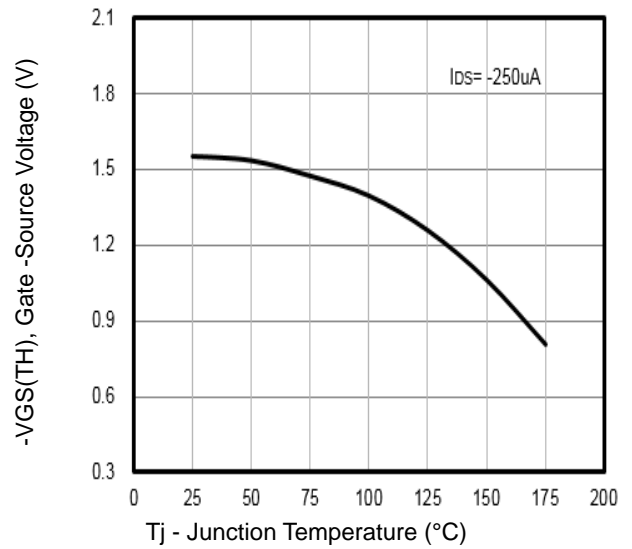


Fig2. $-V_{GS(TH)}$ Gate -Source Voltage Vs. T_j

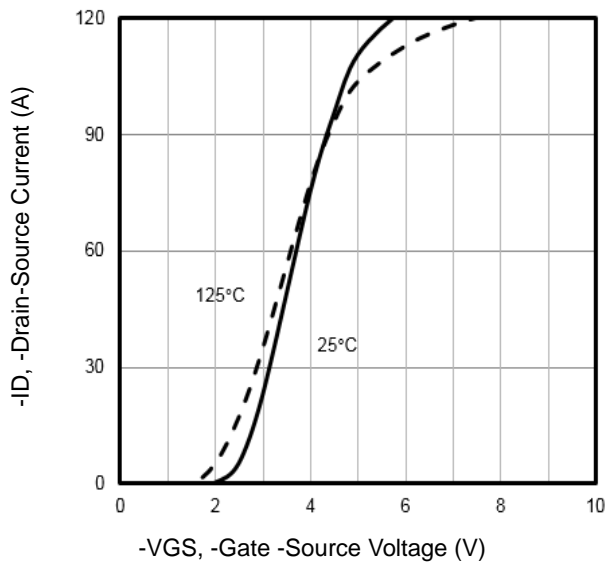


Fig3. Typical Transfer Characteristics

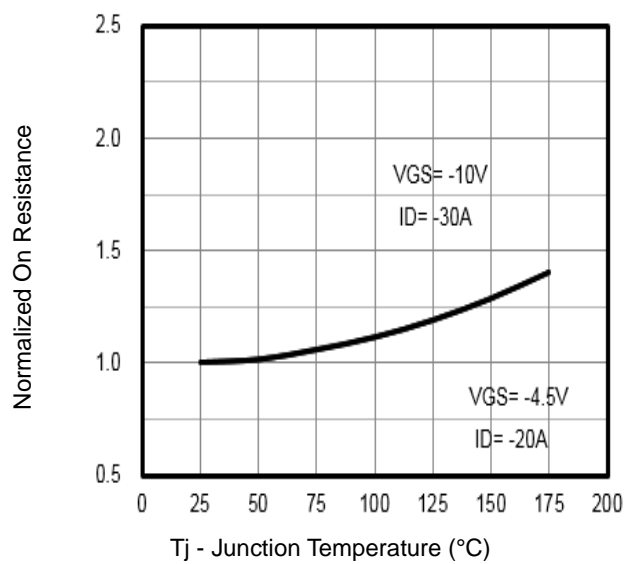


Fig4. Normalized On-Resistance Vs. T_j

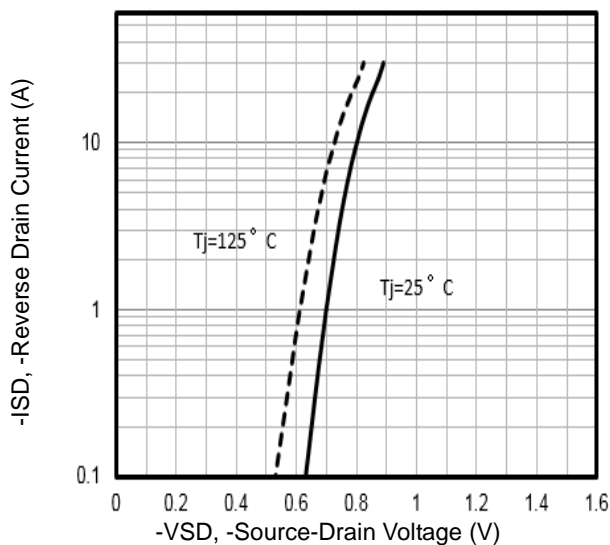


Fig5. Typical Source-Drain Diode Forward Voltage

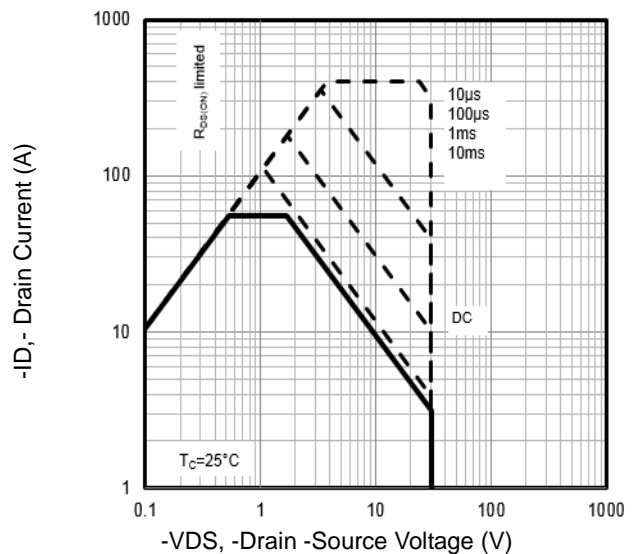


Fig6. Maximum Safe Operating Area

Typical Characteristics

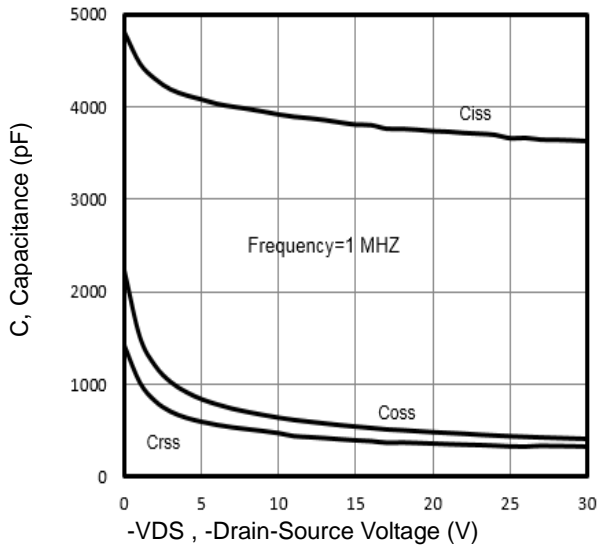


Fig7. Typical Capacitance Vs.Drain-Source Voltage

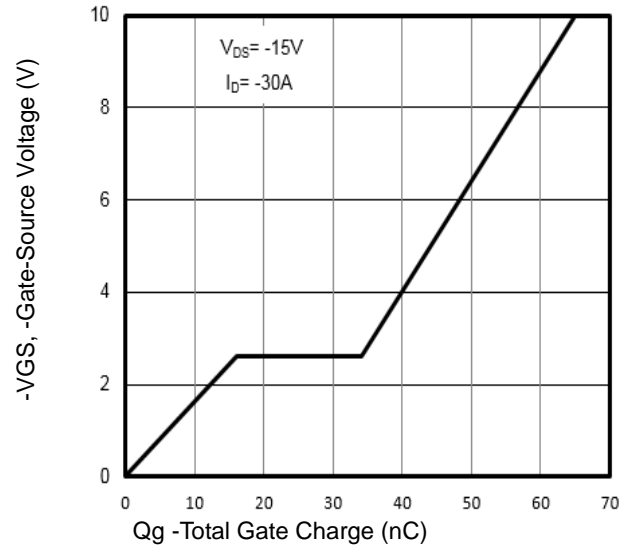


Fig8. Typical Gate Charge Vs.Gate-Source Voltage

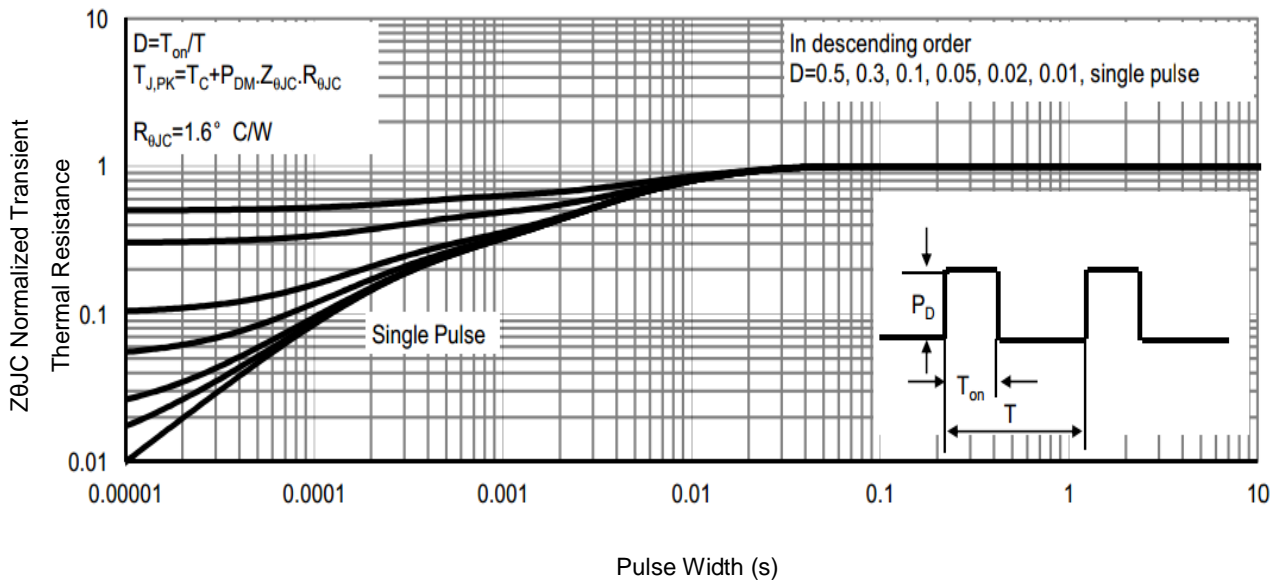


Fig9. Normalized Maximum Transient Thermal Impedance

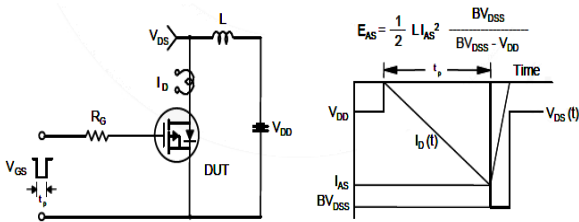


Fig10. Unclamped Inductive Test Circuit and Waveforms

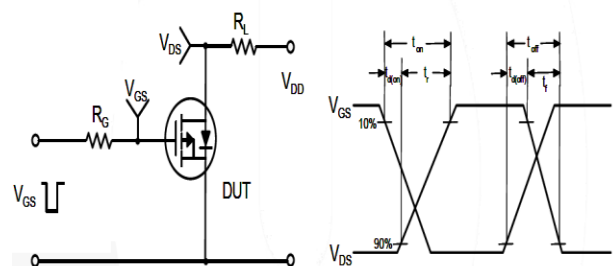
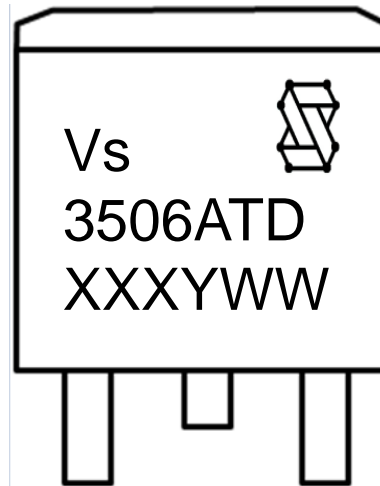


Fig11. Switching Time Test Circuit and waveforms



Marking Information



1st line: Vanguard Code (Vs), Vanguard Logo

2nd line: Part Number (3506ATD)

3rd line: Date code (XXXYWW)

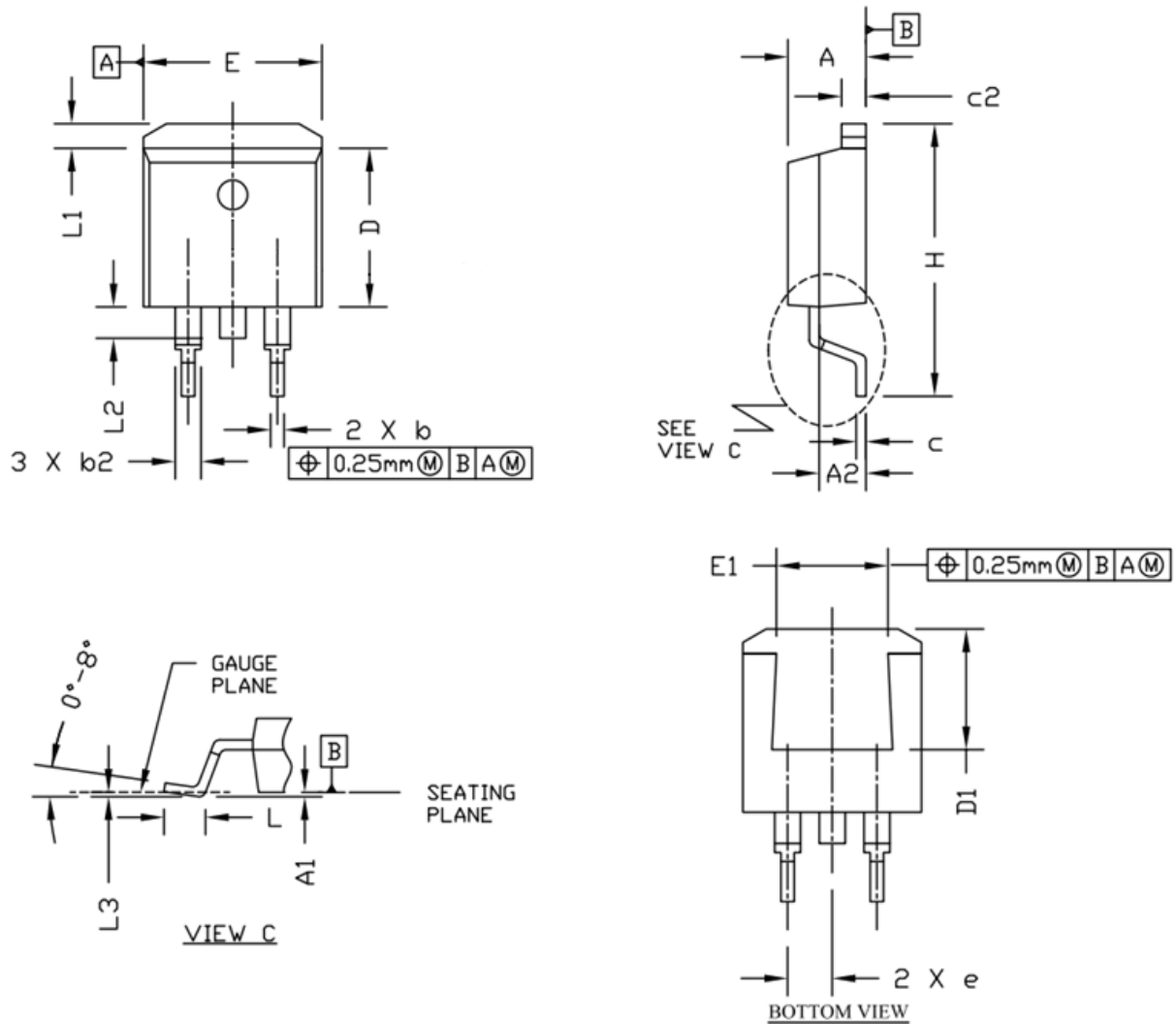
XXX: Wafer Lot Number

Y: Year Code, e.g. E means 2017

WW: Week Code



TO-263 Package Outline Data



Symbol	Dimensions (unit: mm)		
	Min	Typ	Max
A	4.400	4.570	4.700
A1	0.000	0.100	0.200
A2	2.300	2.400	2.500
b	0.700	0.800	0.900
b2	1.200	1.270	1.360
c	0.381	0.500	0.737
c2	1.220	1.300	1.350
D	8.600	9.200	9.300
D1	6.860		
e	2.540 BSC		
E	9.780	9.880	10.260
E1	6.225		
H	14.700	15.100	15.500
L	2.000	2.550	2.750
L1	1.000	1.200	1.400
L2	1.300	1.600	1.700
L3	0.255 BSC		

Notes:

1. Refer to JEDEC TO-263 variation AB
2. Dimension "D" & "E" do NOT include mold flash, mold flash shall not exceed 0.127mm per side.

Customer Service

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